

INFORMATION DISCLOSURE STATEMENT

In compliance with the duty of disclosure under 37 C.F.R. §1.56 and in accordance with the practice under 37 C.F.R. §§1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449.

In accordance with the provisions of 37 C.F.R. §1.98(d), copies of the listed documents are not enclosed as they are of record in parent Application No. 09/301,583 and Application No. 10/293,322.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			ATTY DOCKET NO. 03500.013494.2		APPLICATION NO. Unassigned Divisional of Appln. No. 10/293,322		
			APPLICANT MASAHIRO FUSHIMI, ET AL.				
			FILING DATE Concurr ntly Herewith			GROUP 2879	
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		3,921,873	11/1975	Dahlberg, et al.	225	2	
		4,524,894	06/1985	Leblond	225	2	
		4,904,895	02/1990	Tsukamoto, et al.	313	306	
		5,066,883	11/1991	Yoshioka, et al.	313	306	
		5,107,112	04/1992	Yanagisawa, et al.	250	306	
		5,133,491	07/1992	Correll, et al.	225	1	
		5,220,555	06/1993	Yanagisawa, et al.	369	126	
		5,299,184	03/1994	Yamano, et al.	369	44.280	
		5,371,727	12/1994	Shido, et al.	369	124	
		5,407,116	04/1995	Nishishita, et al.	225	2	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		58-016433	01/1983	Japan			
		63-274047	11/1988	Japan			
		01-031332	02/1989	Japan			
		02-257551	10/1990	Japan			
		03-055738	03/1991	Japan			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		Marton, L., "Advances in Electronics and Electron Physics," Vol. III, pp. 89-185 (1956).					
		Mead, C.A., "Operation of Tunnel-Emission Devices," Journal of Applied Physics, Vol. 32, No. 4, pp. 646-652 (1961).					
		Elinson, M.I., t al., "Th Emission of Hot Electrons and the Field Emission of El ctions from Tin Oxide," Radio Engineering and El ctronic Physics, No. 7, pp. 1290-1295 (1965).					
EXAMINER				DATE CONSIDERED			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include cop. form with next communication to applicant.

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*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
		5,485,451	01/1996	Yamano, et al.	369	126	
		5,532,548	07/1996	Spindt, et al.	313	422	
		5,561,343	10/1996	Lowe	313	482	
		5,673,476	10/1997	Akaike, et al.	29	825	
		5,675,212	10/1997	Schmid, et al.	313	422	
		5,717,287	02/1998	Amrine, et al.	313	495	
		5,721,050	02/1998	Roman, et al.	428	397	
		5,726,529	03/1998	Dean, et al.	313	495	
		5,734,224	03/1998	Tagawa, et al.	313	493	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
		04-028137	01/1992	Japan			
		0 616 354 A2	03/1998	Europe			
		08-180821	07/1996	Japan			
		08-241049	09/1996	Japan			
		08-241666	09/1996	Japan			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
		Hartwell, M., et al., "Strong Electron Emission From Patterned Tin-Indium Oxide Thin Films," International Electron Devices Meeting, Washington, D.C. pp. 519-521 (1975).					
		Myer, R., et al., "Recent Development On 'Microtips' Display Leti," Technical Digest of IVMC 91, pp. 3-6, Nagahama (1991).					
		Spindt, C.A., et al., "Physical Properties of Thin-Film Field Emission Cathodes with Molybdenum Cones," Journal of Applied Physics, Vol. 47, No. 12, pp. 5248-5263 (1976).					
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U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
		5,746,635	05/1998	Spindt, et al.	445	24	
		5,760,538	06/1998	Mitsutake, et al.	313	422	
		5,785,569	07/1999	Stansbury, et al.	445	25	
		5,811,927	09/1998	Anderson, et al.	313	495	
		5,989,090	11/1999	Perrin, et al.	445	24	
		6,152,796	11/2000	Nakata	445	24	
		6,308,391	10/2001	Blaimschein, et al.	83	875	
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATI ON YES/NO/ OR ABSTRACT
		08-241670	09/1996	Japan			
		08-250032	09/1996	Japan			
		0 814 491 A2	12/1997	Europe			
		10-080798	03/1998	Japan			
		10-326579	12/1998	Japan			
		10-220216	08/1998	Japan			
		1996-0002248	11/2000	Korea			
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
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